

<b>Notice of References Cited</b>	Application/Control No. 10/695,302	Applicant(s)/Patent Under Reexamination ANDOH ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-5,481,795	01-1996	Hatakeyama et al.	29/852
*	C	US-6,197,407	03-2001	Andou et al.	428/209
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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